

Portable vibration analyzer for Equipment Diagnosis and On-site Measurements

Vibration Meter VA-12 With FFT analysis function



Compact & Lightweight

Vibration Analyzer VA-12

Major Application Fields

Product Development Quality Assurance Maintenance Simple Diagnosis Precision Diagnosis Vibration measurement at various stages of product development Pre-shipment testing, post-installation operation checks Startup testing after periodic maintenance and servicing Daily routine checks and monitoring of unusual vibration conditions Measurement of problem vibrations and detection of fault sources

Vibration Meter Mode

Allows simultaneous measurement of acceleration, velocity, displacement, and acceleration crest factor



Vibration meter mode

FFT Analyzer Mode

- Real-time analysis frequency 20 kHz Time waveform display and
- spectrum display with up to 3 200 spectral lines. Envelope processing also supported.
- Vibration waveform data recording function(10 seconds at analysis frequency 20 kHz)

Data stored in WAVE file format on memory card (SD card). Timer controlled automatic

measurement



Spectrum display (3 200 lines)

re 🖪 1961MB 001

Hz

ZMc1

Overlapping of stored data

1000.000.



Menu Mode

location.

The crisp color TFT display (240 x 320 dots) is easy

Display

Print

to read, whether outdoors, indoors, or in a dark

Suctor

Analos Input

FFT

Recall

MENU

Menu

₽ Return

nt Ser

Time waveform display



List display (top 10)



Spectrum after envelope processing



USB port allows use of unit as removable disk

Bottom view 1



SD card slot
Trigger input connector
USB port
AC adapter connector



RION 512m

Vibration Meter Mode

Displacement / Acceleration / Velocity Simultaneous Measurement of **Three Components**



Values used to express vibration magnitude



Peak value......Maximum value of single-sided amplitude RMS value......Root mean square of instantaneous value P-P value(peak-to-peak value)

... Maximum difference between highest and lowest value Equivalent peak value......RMS value multiplied by $\sqrt{2}$ Equivalent P-P valueRMS value multiplied by $2\sqrt{2}$ Crest factor.....Peak value/RMS value

Vibration explained

Mechanical vibrations can be represented as a complex combination of a spring and weight, as shown in the illustration on the right. The basic physical quantities that define vibration are displacement, velocity, and acceleration. By measuring each of these values. the vibration condition can be assessed



Displacement explained

Unit: : µm, mm, etc. The movement distance (travel) from a reference point is called displacement.

For example, if a car travels a distance of 100 meters, the displacement value is 100 m. When considering vibrations, the movement distance of the vibrating object from the stationary rest position is the displacement, which changes between positive and negative values



Velocity explained

Unit : mm/s, m/s, etc.

This quantity expresses the amount of change per unit of time. It is related to the vibration energy.

For example, if a car travels a distance of 100 meters in 10 seconds, the velocity is the distance (100 m) divided by the time (10 s), i.e. 10 m/s. When considering vibrations, the displacement magnitude and direction change over a short span of time, and the velocity therefore is not usually constant. The following relationship exists:

Velocity = displacement x 2 π x vibration frequency



Acceleration explained

Unit : m/s², mm/s², etc.

Acceleration is the change in velocity per unit of time.

It is proportional to the impact force or other external force. For example, if a car traveling at a velocity of 10 m/s changes to a velocity of 30 m/s over a period of 2 seconds, the acceleration is the change in velocity (20 m/s) divided by the time (2 s), i.e. 10 m/s². When considering vibrations, the velocity and direction change over a short span of time, and the acceleration therefore is not usually constant.

The following relationship exists:

Acceleration = velocity x 2 π x vibration frequency



Usage of displacement, velocity, and acceleration

Displacement

- Measurement of vibrations in a low frequency range (below 200 Hz)
- Cases where displacement as such is critical
- Assessment of wear and damage related to static deformation,
- such as the effects of tensile force or compression
- Assessment of contact risks and machining precision

Velocity

- Measurement of vibrations in a medium frequency range(10 Hz to 1 kHz)
- Detection of imbalance, misalignment, bolt loosening, rattle and play etc.
- Assessment of vibration severity (ISO 10816, JIS B 0906)
- Assessment of metal fatigue

Acceleration

- Measurement of vibrations in a high frequency range (above 1 kHz)
- Detection of bearing and gear defects etc.

Vibration Meter Mode Applications

Simple Diagnosis

Vibration magnitude

Measuring the magnitude of vibrations is a useful diagnostic technique for ascertaining that machinery is operating normally and checking for signs of possible problems.

For example, when vibrations exceeding the reference value in the velocity range (up to 1 000 Hz) are detected, the presence of an imbalance, misalignment, or loosening condition can be suspected, whereas vibrations in the acceleration range (1 kHz to about 12 to 15 kHz) point to possible bearing or gear problems.

Crest factor

The crest factor (C.F.) is an indication of the impact characteristics of a waveform. It is determined by the ratio between the RMS and peak values. Higher crest factor values indicate a stronger impact quality. The crest factor of acceleration measurements is useful for detecting the early stages of bearing damage.

Crest factor= Peak value RMS value

The vibration waveform of a bearing with a fault in the initial stage is shown in the example below. Compared to the waveform of a normal bearing, the crest factor is higher.

Normal bearing

(Peak value / RMS value = crest factor is small)

RMS value Peak value With Martin Marth Marth



Bearing with spot damage

(Peak value / RMS value = crest factor is large)



Maintenance Management of Machine Equipment

By periodically measuring the vibration magnitude and comparing the results to a reference value, the equipment condition (normal or potential problem) can be diagnosed.

Using an absolute evaluation standard

ISO 10816 series (Evaluation of machine vibration by measurements on non-rotating parts).

According to ISO 10816-1:1995 / Amd. 1:2009, evaluation criteria for mechanical vibration over a specified range are to be decided by agreement between the supplier and the user of the machine, and boundary values for evaluation are to be determined in consideration of the measurement position and the support rigidity of the machine etc.

Reference value

- A: Newly installed machinery will normally be within this range.
- B: Long-term continuous operation allowed.
- C: Long-term continuous operation not allowed,
- but limited-term operation allowed.
- D: High risk of injury. Operation not allowed.

Using a relative evaluation standard (trend management)

Using the normal condition as a reference, threshold values for caution and hazard conditions are set.

When the caution level is exceeded, monitoring is reinforced, and detailed diagnosis is performed when the hazard level is exceeded. A commonly used factor for setting the levels is as follows: caution level = 2 to 3 times the normal value, hazard level = 2 to 3 times the caution value.

After deciding on the vibration measurement location, measurement direction, and measurement frequency, a time series graph is commonly used for trend management, comprising measurement values and other data.

Representative zone boundary values





Trend management diagram

FFT Analyzer Mode

The Need for Frequency Analysis

Machinery usually comprises a variety of vibration sources such as motors, gears, bearings, fans, etc. When devising measures to minimize vibrations and when trying to locate the causes of problematic vibrations, measuring only the magnitude of vibrations often will not provide enough information. It is also necessary to perform frequency analysis, in order to determine which types of vibrations exist and what their levels are.

As shown in the illustration, the locations where vibrations occur will affect the vibration frequency. Frequency analysis makes it possible to pinpoint vibration sources with greater accuracy.



Spectrum

Vibration amplitudes are shown for each frequency. The time waveform is divided into constant intervals, and FFT analysis* is performed for these intervals. A sine wave will have only one line spectrum, but complex machine vibrations will show peaks at various frequencies.

* FFT (Fast Fourier Transform) analysis is a type of frequency analysis that is particularly suited to analyzing machine vibrations.





Time Waveform

This shows the variations over time at the location of the accelerometer.

It provides information that is not available from the spectrum display, such as whether the vibration is normal or impact related, whether it has shifted upwards or downwards, etc.

FFT Analyzer Mode Applications

Product Quality Control

When testing products on manufacturing lines for unusual vibrations, frequency analysis can be very helpful. For example, when targeting a specific frequency, it can be determined whether there are vibration components in the adjacent frequency range. Using the frequency spectrum with a known good product as reference, comparative analysis can be applied to pass / fail evaluation.





Comparison to reference spectrum (Overlapping of stored data)

FFT Analyzer Mode Applications

Precision Diagnosis of Rotating Machinery

Precision diagnosis is used to determine the cause of problems as well as the extent, location etc.

Bearings

Bearing problems will cause a significant increase in acceleration values. As seen in the example, envelope analysis shows the peaks at equal intervals. When the size, number of rolling elements, axis rotation speed and other parameters are known, the primary frequency of the lined-up peaks will provide information about the problem location.



When diagnosing a bearing fault, it is necessary to know the repeat cycle of the impact waveform. This can be achieved by envelope processing, using the principle illustrated below.



Misalignment

When there is a misalignment, large vibration components that are an integral multiple of the rotation speed will appear in the axis direction. The type of bearing joint affects the multiplication factor. In the example shown here, there are large vibration components with a factor of 3.



Misalignment explained

When two coupled rotating axes are not properly centered on relation to each other, their centers of rotation will not be in linear alignment. This is called misalignment, which can be either relative to the core or the face or a combination of the two.

When misalignment occurs, the thrust load on the bearing increases due to end face runout, resulting in shorter bearing life.



Imbalance

When there is an imbalance, large vibration components at a frequency equal to the rotation speed will appear in the circumferential direction. Vibrations of other frequencies will be largely absent. The vibration amplitude is proportional to the imbalance magnitude. At higher rotation speeds, the vibration amplitude is proportional to the square of the rotation frequency.



Imbalance explained

This is a condition where the center of gravity of a rotating body has shifted from the center line. There are various types of imbalance, including static imbalance, couple imbalance, and dynamic imbalance. When an imbalance occurs, the load on the bearing in the circumferential direction increases, resulting in shorter bearing life.



Measuring the Resonance Frequency of a Structure

When an external force at a frequency close to the resonance frequency is applied to a structure, strong vibration will occur. This can lead to breakdown of machinery, product quality degradation, and other problems. In order to guard against such risks, measuring the resonance frequency is very important.

In the example shown at right, multiple resonance frequencies at 8 Hz, 98 Hz etc.

exist.





To measure the resolution frequency, the structure is struck with a hammer or similar and the resulting vibrations are subject to frequency analysis.

Specifications

	OF module a Obiese a Del 10 (conset model for Obiese and a)	
Standard compliance UE marking, Chinese RoHS (export model for China on		
Input costion	WEEE DIrective	
Number of measurement	1	
	PNIC CCL D 18 V 2 mA (CCL D24 V 4 mA available as factory option)	
Seneor	Piezoelectric Accelerometer PV-577 (cupplied)	
Input range		
At sensitivity 0.1	$\Omega\Omega \ to \ \Omega \ 999 \ mV/(m/s^2)$	
	$10,316,100,316,1000,3160,10,000,m/s^2 (rms)$	
VEL (Velocity)	31.6.100.316.1.000.3.160.10.000.31.600 mm/s (rms)	
DISP (Displacement)	0.89, 2.83, 8.94, 28,3, 89,4, 283, 894 mm (EQn-n)	
At sensitivity 1.0	$0 \text{ to } 9.99 \text{ mV/(m/s^2)}$, using PV-57I	
ACC (Acceleration)	$1, 3, 16, 10, 31, 6, 100, 316, 1000 \text{ m/s}^2 \text{ (rms)}$	
VEL (Velocity)	3.16, 10, 31.6, 100, 316, 1 000, 3 160 mm/s (rms)	
DISP (Displacement)	0.089, 0.283, 0.894, 2.83, 8.94, 28.3, 89.4 mm (EQp-p)	
At sensitivity 10.	.0 to 99.9 mV/(m/s²)	
ACC (Acceleration) 0.1, 0.316, 1, 3.16, 10, 31.6, 100 m/s ² (rms)		
VEL (Velocity)	0.316, 1, 3.16, 10, 31.6, 100, 316 mm/s (rms)	
DISP (Displacement)	0.0089, 0.0283, 0.0894, 0.283, 0.894, 2.83, 8.94 mm (EQp-p)	
Measurement range	using PV-57I, High-pass filter 3 Hz, Low-pass filter 20 kHz)	
ACC (Acceleration)	0.02 to 141.4 m/s ² (rms) Continuous measurement, 1 Hz to 5 kHz	
Instantaneous	700 m/s ²	
maximum acceleration		
VEL (Velocity)	0.2 to 141.4 mm/s (rms) at 159.15 Hz	
DISP (Displacement)	0.02 to 40.0 mm (EQp-p) at 15.915 Hz	
Measurement freque	ncy range (electrical characteristics)	
ACC (Acceleration)	1 Hz to 20 kHz	
VEL (Velocity)	3 Hz to 3 kHz	
DISP (Displacement)	3 Hz to 500 Hz	
Acceleration envelope curve	1 kHz to 20 kHz	
Filters		
Prefilters		
High-pass filter	1 Hz (acceleration only), 3 Hz, 10 Hz, 1 kHz (-10 % point), cutoff slope -18 dB/oct	
Low-pass filter	1 kHz, 5 kHz, 20 kHz (-10 % point), cutoff slope -18 dB/oct	
Acceleration enve	elope curve filter	
High-pass filter	1 kHz (-10 % point), cutoff slope -18 dB/oct	
Inherent noise	High-pass filter 3 Hz, Low-pass filter 20 kHz, lowest range setting	
ACC (Acceleration)	0.01 m/s ² (rms) or less	
VEL (Velocity)	0.1 mm/s (rms) or less	
DISP (Displacement)	0.01 mm (EQp-p) or less	
A/D conversion	24 bit ∆Σprinciple, 51.2 kHz	
Dynamic range	Maximum 110 dB (Acceleration)	
Vibration meter mode		
ACC (Acceleration)	m/s ² rms value, waveform peak value, crest factor	
VEL (Velocity)	mm/s rms value	
DISP (Displacement)	mm EQp-p	
FFT mode	Time waveform, spectrum, Acceleration envelope curve	
Analysis points	512, 1 024, 2 048, 4 096, 8 192 (3 200 lines)	
Time window functions	Rectangular, Hanning, flat-top	
Processing	Linear average, maximum, exponential averaging, instantaneous value	
Frequency span	100 Hz, 200 Hz, 500 Hz, 1 kHz, 2 kHz, 5 kHz, 10 kHz, 20 kHz	
Display		
Spectrum	I op I 0 list, graph display (excluding DC)	
Zoom	X axis : x1, x2, x4, x8, x16	
	Y axis : 2 ^N , N = 0 to 10 (x1 to x1024)	
Overlay display w	Ith stored data in spectrum mode	
Time wave form	Graph display	
Zoom	X axis : x1, x2, x4, x8, x16, x32	
	Y axis : 2 ^N , N = 0 to 14 (x1 to x16 384)	
Irigger		
Trigger source		
External signal	Iriggered at falling edge of signal at external trigger input	
Input level	Triggered when time waveform crosses a preset level	
	Trigger level can be set in steps of 1/8 of full scale on one-sided amplitude	
Slope	+/- trigger operation	
Trigger operation		
Free-run	Processing always carried out, regardless of trigger condition	
Repeat	Processing carried out whenever triggering occurs	
Single	Processing carried out once only when triggering occurs	
Time	Data are stored according to the setting of Trigger Start Time,	
	Store Interval, Store number.	

Protriggor	Processing starts from data 1/8 frame time ahead	
Dicplay	Color TET LCD, 240 x 220 date, with backlight	
Dispidy	Lenences display. English display Time display	
	Japanese display, English display, Time display	
warning indication	LED (lights up in red to indicate overload)	
Memory		
Memory media	SD cards (max. 2 GB)*	
Store files	Sets of measurement values and parameters can be stored on memory card	
	1 000 data saved as one store name. Max. number of store names: 100	
Parameter setting	Up to 5 parameter sets can be stored in unit	
memory	Parameter settings can be stored on memory card	
Wave files	Up to 10 seconds per file (frequency range 20 kHz)	
	Vibration waveform recorded during FFT processing	
	available when using a computer.	
BMP files	Screen capture can be saved as BMP files.	
Recall function	Measurement data can be read from memory card and redisplayed on screen.	
Resume function	Settings are memorized when power is turned off and can be restored at next power-or	
Input/output section		
Trigger input connecto	TTL level, BNC-mini plug, 2.5 mm dia. (for CC-24)	
USB port Removable	Allows use of memory card inserted in unit as removable storage	
disk functio	n device (removable storage device class)	
Power		
DC12 V (11 to 15 V	AC adapter NC-99, eight IEC R6 (size AA) batteries	
	(23°C, normal operation, backlight off)	
Battery life	Approx. 12 hours	
Current consumption	145 mA (normal operation, backlight off)	
Power consumptior	Approx. 10 VA (in case of AC 100 V (NC-99))	
(primary side)		
Ambient temperature and		
humidity conditions for use		
Accelerometer	-20 °C to +70 °C, 90 % RH or less	
Main unit	-10 °C to +50 °C, 90 % RH or less (no condensation)	
Dimensions, Weight	213 (H) x 105 (W) x 36 (D) mm; Mass Approx. 850 g (incl.	
	batteries, with protective cover, PV-57I connected)	
Supplied accessories	Piezoelectric Accelerometer PV-57I, Curled cable, Magnet attachment	
	IEC B6 (size AA) battery x 8 SD card Protective cover. Shoulder belt	
	IESTIS (SIZETA) BALLERY X 0, SE CARA, I TOLESLIVE COVEL, SHOULDER DEL	

Option

Name	Model		
Waveform Analysis Software	AS-70		
Piezoelectric accelerometer	Various		
BNC Adapter	VP-52C		
Charge converter	VP-40		
SD-CARD 512 MB*	MC-51SS1		
SD-CARD 2 GB*	MC-20SS2		
BNC-mini plug Cable	CC-24		
AC Adapter	NC-99		

*Use only RION supplied cards for assured operation

Option Waveform Analysis Software AS-70

AS-70 allows post-processing using stored waveform file data from VA-12





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